

ID	R _{Ds} (ON)(Typ)	VDSS
ЗA	5.2Ω	1600V

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS3N150PF	TO-3PF	RS3N150PF	Tube	30 PCS

Absolute Maximun Ratings Tc= 25° unless otherwise specified

Symbol	Parameter	RS3N150PF	Units
VDSS	Drain-to-Source Voltage	1600	V
ID	Continuous Drain Current TC=25 $^{\circ}$ C	3	٨
IDM	Pulsed Drain Current (Note*1)	12	A
PD	Power Dissipation	69	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	88	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the" Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS3N150PF	Units	Test Conditions
RØJC	Junction-to-Case	1.8	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\mathrm{C}$
RθJA	Junction-to- Ambient	40		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	1600			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=1600V,VGS =0V
	Gate- to- Source Forward Leakage			100	~ ^	VGS=30V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		5.2	6.4	Ω	VGS=10V,ID=1.5 A
VGS(TH)	Gate Threshold Voltage	3		5	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		45			
trise	Rise Time		22.5			VDS=750V
td(OFF)	Turn- OFF Delay Time		224		nS	ID=3A RG=25Ω
tfall	Fall Time		55.5			



Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1348			VGS=0V
Coss	Output Capacitance		101		pF	VDS=25V
Crss	Reverse Transfer Capacitance		15			f=1.0MHz
Qg	Total Gate Charge		54.5			VDS=1200V
Qgs	Gate- to- Source Charge		6.4		nC	ID=3A
Qgd	Gate-to-Drain(" Miller") Charge		31.5			VGS=10V

Dynamic Characteristics Essentially independent of operating temperature

Source- Drain Diode Characteristics

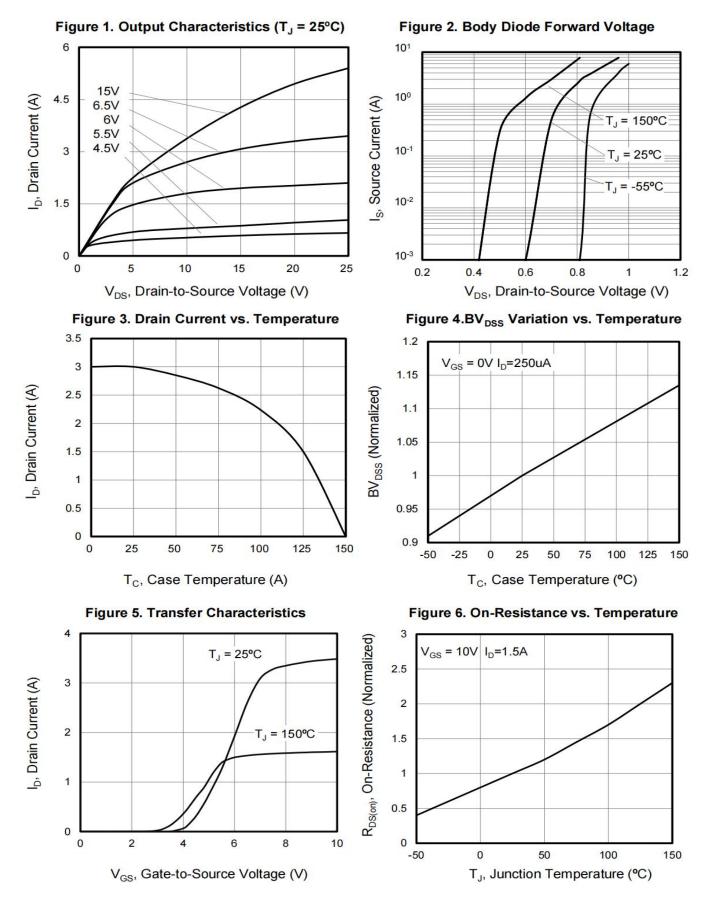
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			3	А	Integral pn- diode
ISM	Maximum Pulsed Current			12	А	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=1.5A,VGS=0V
trr	Reverse Recovery Time		647. 5		nS	VGS=0V IS=3A,di/dt=100A
Qrr	Reverse Recovery Charge		0.98		μC	/μs

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%



Typical Feature Curve





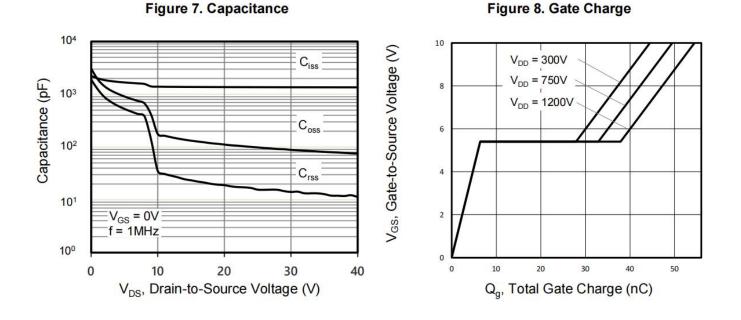
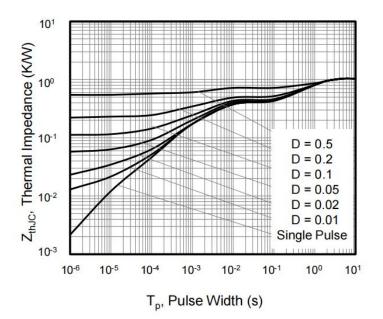


Figure 9. Transient Thermal Impedance





Test Circuits and Waveforms

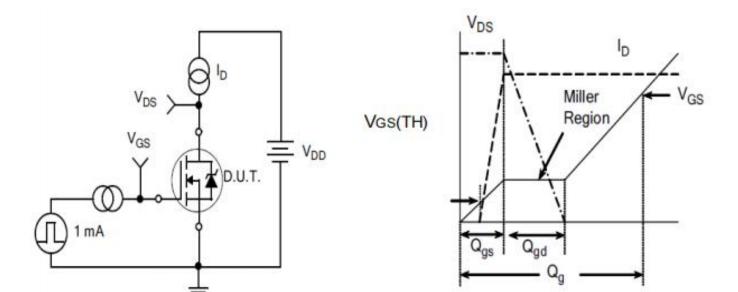
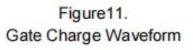


Figure10. Gate Charge Test Circuit



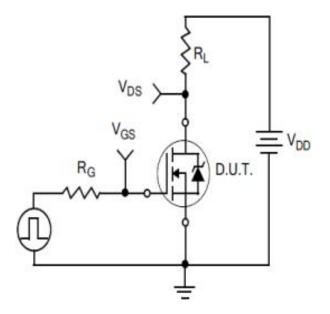


Figure12. Resistive Switching Test Circuit

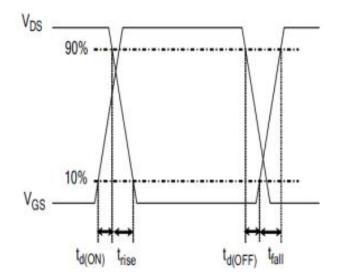
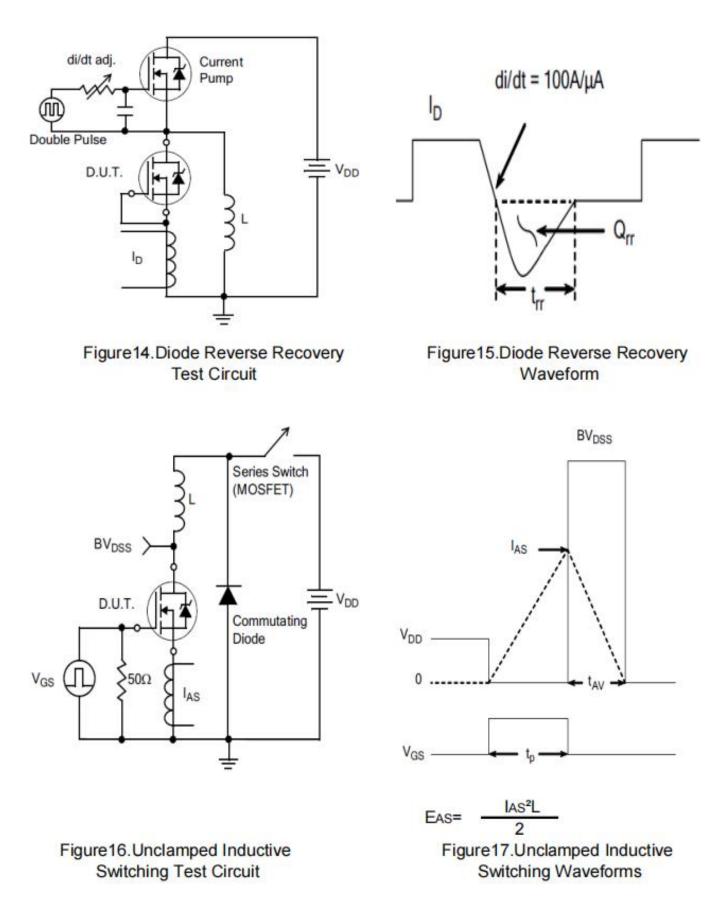


Figure13. Resistive Switching Waveforms



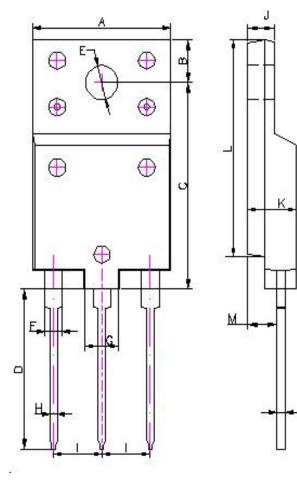
Test Circuits and Waveforms





Package outline drawing(TO-3PF Unit: mm)





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SYMBOLS	MIN	MAX		
A	15.30	15.70		
В	4.30	4.70		
С	21.80	22.20		
D	16.70	17.30		
Е	3.45	3.75		
F	1.85	2.15		
G	3.85 4			
H	0.75	0.95		
Ι	5.35	5.55		
J	2.80	3.20		
K	5.30	5.70		
L	22.80	23.20		
М	3.25	3.55		
Ν	0.80	1.00		
Р	14.4	15.00		

Ν



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